Printed Pa	ge:-	Subject Code:- AMTVL0114			
		Roll. No:			
	NOIDA INCTITUTE OF ENGINEEDING	AND TECHNOLOGY, CREATER NOIDA			
	NOIDA INSTITUTE OF ENGINEERING A (An Autonom				
	Affiliated to Dr. A.P.J. Abdul Kalam Tech	nical University, Uttar Pradesh, Lucknow			
	M.T SEM: I - THEORY EXAN				
	Sewi. 1 - Theor I Exam Subject: Microchip Fa	· · · · · · · · · · · · · · · · · · ·			
Time: 03	3:00 Hours	Max. Marks: 70			
General In	structions:				
1. All	questions are compulsory. It comprises three S	ections A, B and C.			
shore Section	t type questions carrying 2 marks each. ion B - Question No- 3 is Long answer type - ion C - Question No- 4 to 8 are Long answer t				
	SECTION A	A 15			
1. Attemp	1. Attempt all parts:-				
1-a.	The active components in an IC are (CO1)	1			
	1. Transistors & diodes				
	2. Capacitors				
	3. Registers				
	4. None of these				
1-b.	Silicon oxide is patterned on a substrate using	g(CO2)			
	1. Physical lithography				
	2. Chemical lithography				
	3. Photolithography				
1 .	4. Mechanical Lithography	102)			
1-c.	What is next step after Photolithography? ( C	203)			
	<ol> <li>Oxidation</li> <li>Diffusion</li> </ol>				
	3. Metallization				
	4. Orientation				
1-d.	Choose the incorrect step involved in PVD te	echnique. (CO4)			
	1. Physical ejection of material as ato	-			
	2. Chemical reaction takes place during				
	3. Nucleation of the atoms or molecul	-			
	4. Condensation of the atoms or mole	cules			
1-e.	Deposition rate is given as (CO5)	1			
	1. width per unit time				
	2. thickness per unit time				
	3. sputtering rate per unit time				
	4. depositing rate per unit time				
2. Attempt all parts:-					
2-a.	Identify three trends that have driven the sem	iconductor industry. (CO1)			

2-b.	What do you mean by wafer preparation? (CO2)	2
2-c.	What are the differences between positive and negative photo resist? (CO3)	2
2-d.	What two factors must be present for chemical vapor deposition success? (CO4)	2
2-е.	Why aluminium is preferred for metallization? (CO5)	2
	SECTION B 20	
3. Answer	any five of the following:-	
3	State the stage of processing in which wafers are produced. (CO1)	4
3	List the reasons why silicon is the most common semiconducting material. (CO1)	4
3	Explain layering and patterning technique of wafer fabrication operations. (CO2)	4
3	Explain different types of oxidation methods. (CO2)	4
3-е.	Give some differences between Hard Baking and Soft Baking. (CO3)	4
3-f.	Write a short note on Vapour phase Epitaxy. (CO4)	4
3-g.	Differentiate between Through Hole and Surface mount technology. (CO5)	4
	SECTION C 35	
4. Answer	any one of the following:-	
4	Sketch Float zone method. Write its advantages & disadvantages. (CO1)	7
4	Sketch the CZ process and explain its various parts. Also write its advantages and disadvantages. (CO1)	7
5. Answer	any one of the following:-	
5.a	Explain the preparation of wafers from the crystal ingot. (CO2)	7
5.b	Differentiate among thermal, rapid thermal and high pressure oxidation method. (CO2)	7
6. Answer	any one of the following:-	
6	Explain the process of etching in detail with suitable diagram. (CO3)	7
6	Discuss Pattern Transfer Defects in detail. (CO3)	7
7. Answer	any one of the following:-	
7	Derive expressions for Fick's Second Law of Diffusion. (CO4)	7
7	Sketch the schematic diagram of CVD Reactors and explain its working. (CO4)	7
8. Answer	any one of the following:-	
8	Explain Ceramic Package Technology. With the help of neat diagram discuss the process sequence of a multilayer ceramic technology to create a laminated refractory ceramic product. (CO5)	7
8	Explain the various aspect of thermal and electrical packaging design consideration. (CO5)	7